

Notice of References Cited	Application/Control No. 10/695,624	Applicant(s)/Patent Under Reexamination TOHSCHÉ, ULF	
	Examiner Long Nguyen	Art Unit 2816	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0005745 A1	01-2002	Robertson et al.	327/218
	B	US-			
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	M	US-			

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